

Negative Differential Conductivity of 2D Electron Gas System at High Magnetic Field

Jeng-Chung Chen

Department of Physics
National Tsing-Hua University

Collaborators:

- Yuling Tsai, Kuang Ting Lin, Y. P. Lin (NTHU)
- T. Ueda and S. Komiyama (Univ. of Tokyo)

Acknowledge:

- Cheng-Chung Chi, Chung-Yu Mou

Ref: J. C. Chen*, Yuling Tsai, Yiping Lin, T. Ueda, S. Komiyama, *Phys. Rev. B*, **79**, 075308(2009).



Outline

❖ Introduction:

- Experimental system:
Two-dimensional electron gas system (2DEG)
- Integer Quantum Hall Effect (IQHE)
- Negative differential conductivity (NDC)

❖ Motivation:

- Microwave induced zero resistance states in 2DEG
- NDC at high magnetic field

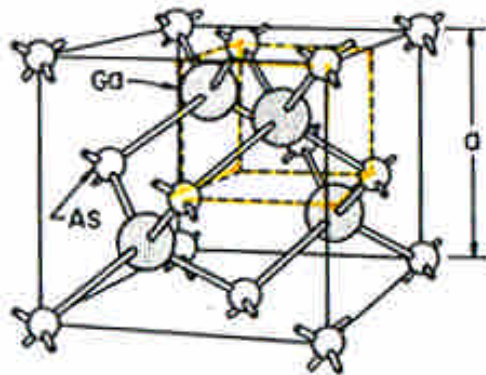
❖ NDC of 2DEG at high magnetic field

- Measurement
- Data analysis – Demonstration and consequence of NDC
- Physical origin of NDC

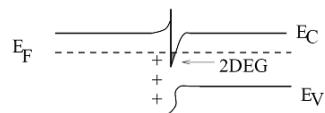
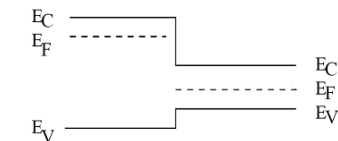
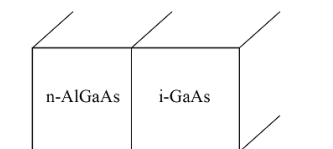
❖ Summary

Experimental system: GaAs-AlGaAs heterostructure

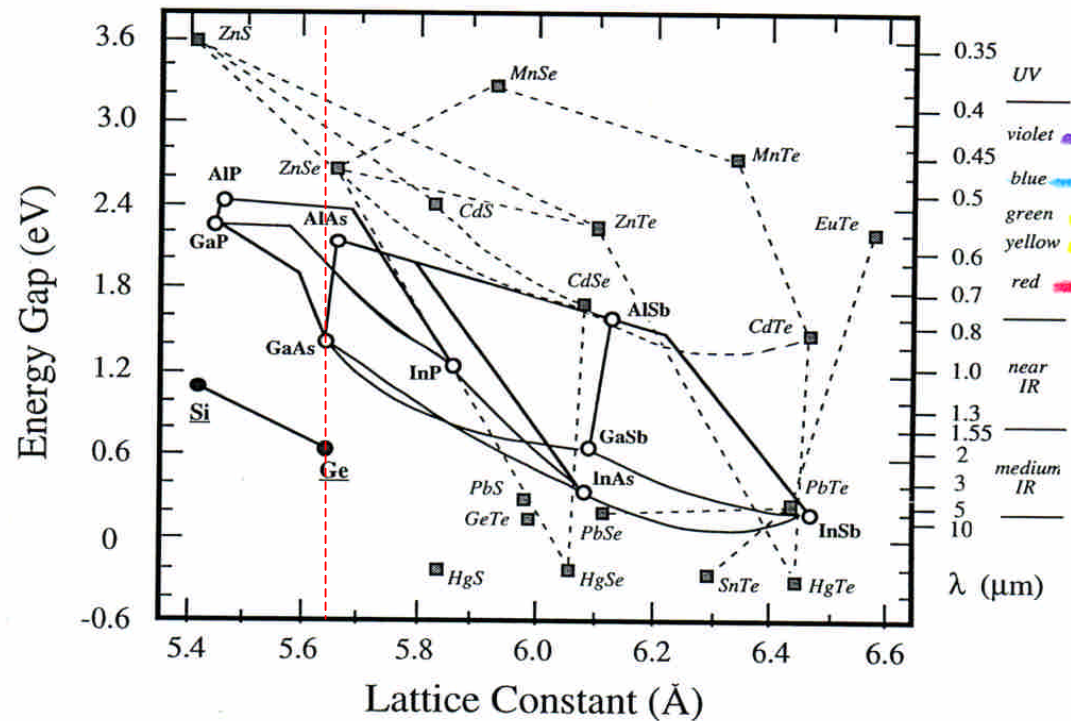
GaAs crystal structure



Heterostructures / band engineering

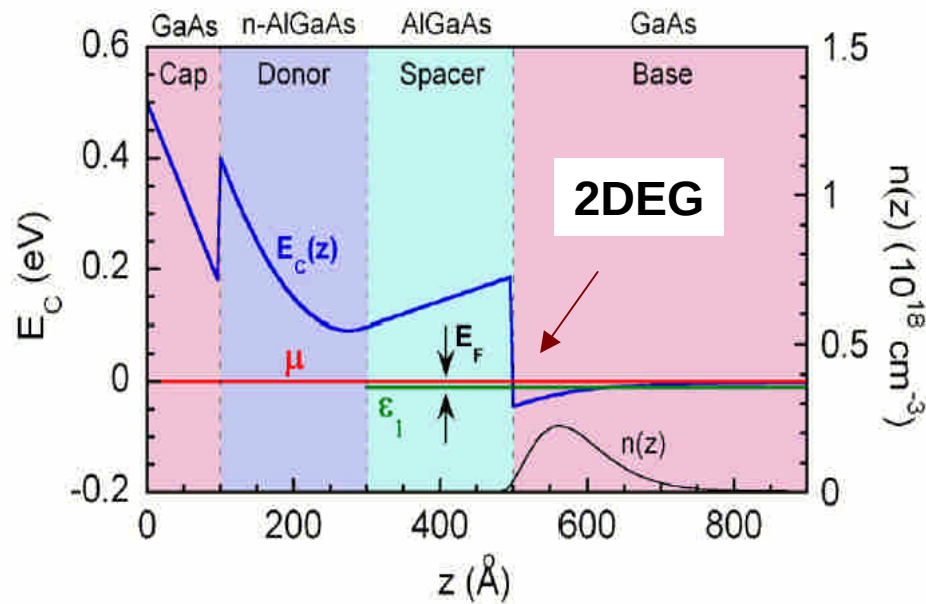


Bandgap energy & Lattice constant for elemental and binary compound semiconductors



	Lattice constant(Å)	Band gap (ev)		Effective mass	Lattice structure	Gap type
GaAs	5.653	1.52	1.43	0.067	Zinc-blende	Direct
AlAs	5.660	2.24	2.16	0.1		Indirect
Al _x Ga _{1-x} As	Linear interpolation between alloy's constituents					x>0.35 indirect x<0.35 direct

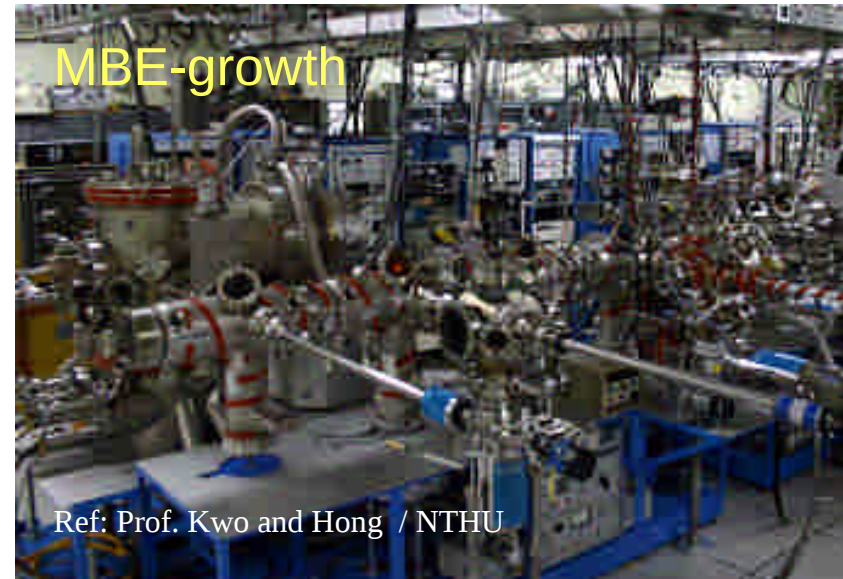
Experimental system: Two dimensional electron gas (2DEG)



2DEG is formed at the interface between GaAs & AlGaAs

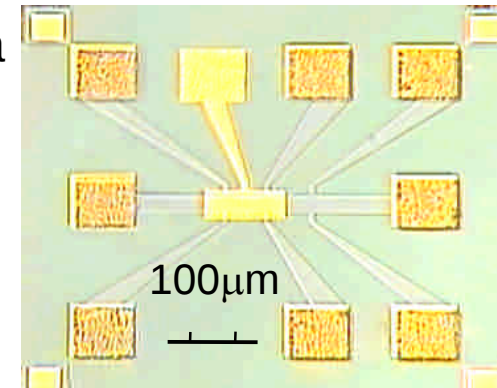
Electronic properties of 2DEG

- Carrier density: $n_s = 1-4 \times 10^{11} \text{ 1/cm}^2$
- Fermi wavelength: $\lambda_F = 40 \text{ nm}$
- Electron mobility: $\mu_e = 10^5 - 10^6 \text{ cm}^2/\text{Vs}$
- Mean free path: $l = 10^3 - 10^4 \text{ nm}$
- Phase coherence length: $l_\phi = 200 \text{ nm}$



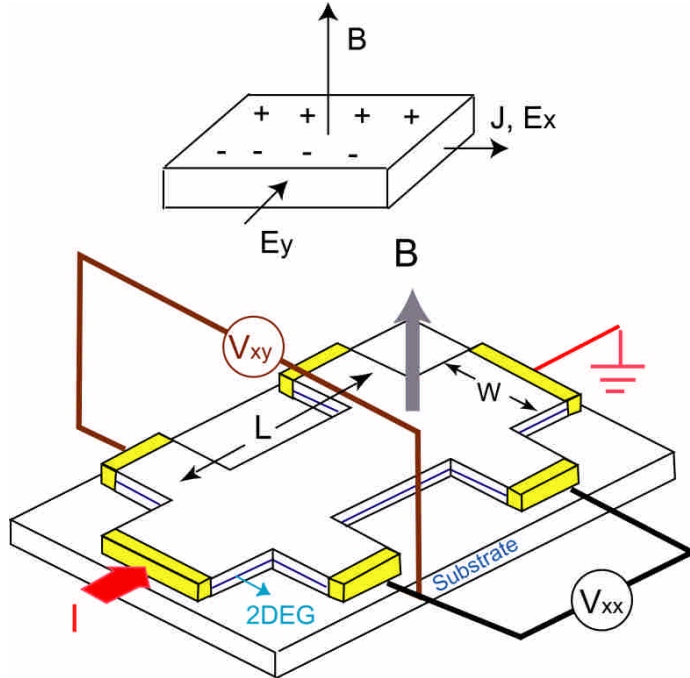
Device Fabrication:

- Photolithography
- Etching // Mesa
- Ohmic contacts / Alloying
- Metallization



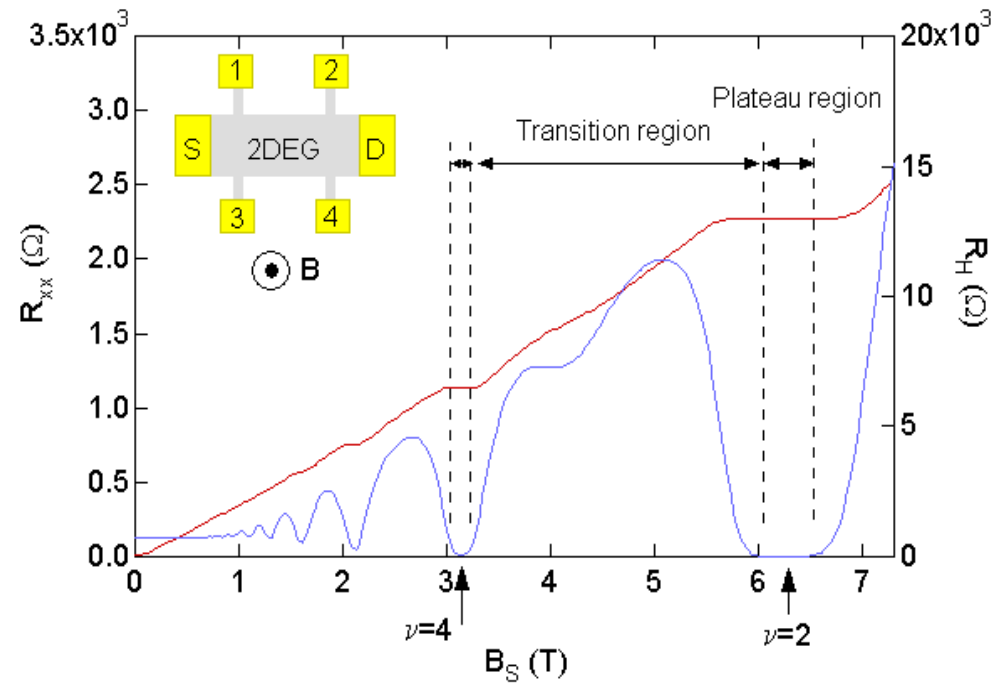
Integer Quantum Hall effect (IQHE)

Hall effect



- $E_x = \rho_{xx} J_x$, $E_y = \rho_{xy} J_x$
- $R_{xx} = \frac{V_{xx}}{I}$, $R_{xy} = \frac{V_{xy}}{I}$
- $\rho_{xx} = \frac{V_{xx}}{I} \frac{W}{L}$, $\rho_{xy} = \frac{V_{xy}}{I}$
- Hall angle : $\Psi = \tan^{-1}(E_y / E_x)$

IQHE experiment



- Temp: 4.2K
- GaAs/AlGaAs 2DEG
- $\frac{h}{e^2} = 25.81k\Omega$

ν : Integer

$$\begin{cases} R_{xx} = 0 \\ R_{xy} = \frac{1}{\nu} \frac{h}{e^2} \end{cases}$$

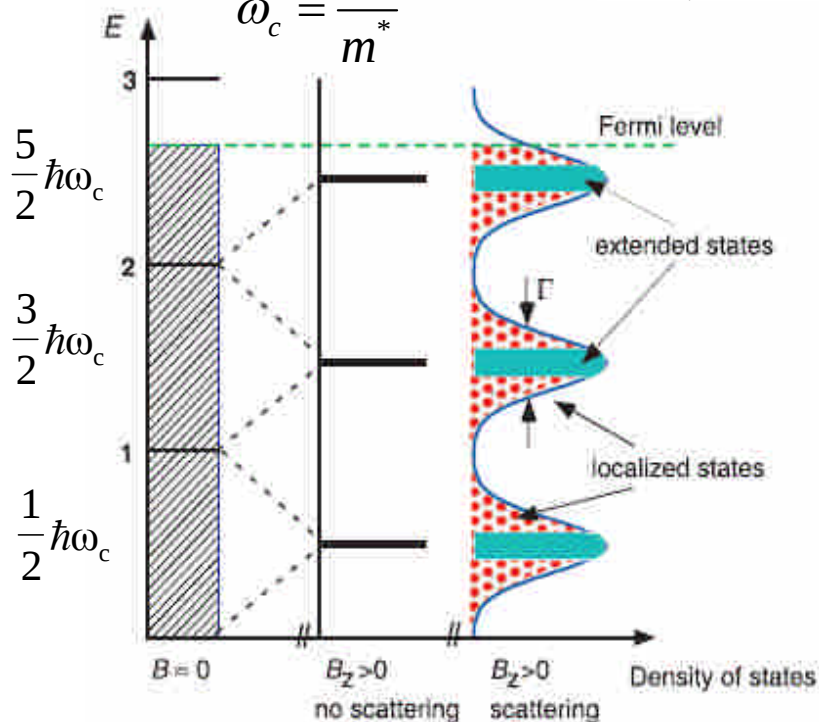
Integer Quantum Hall effect

Landau levels (single particle picture)

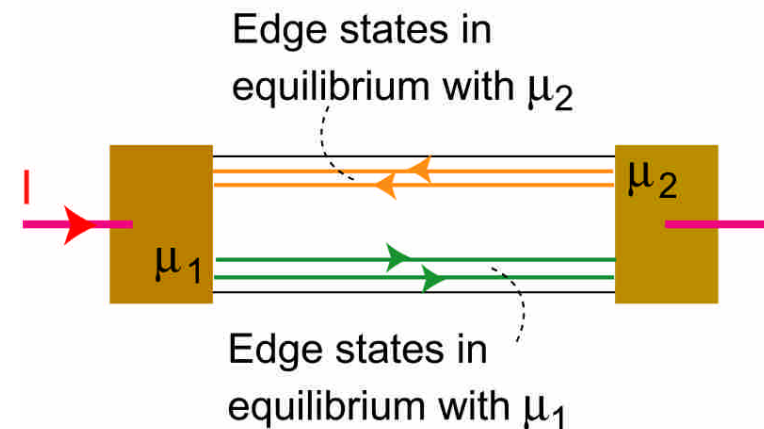
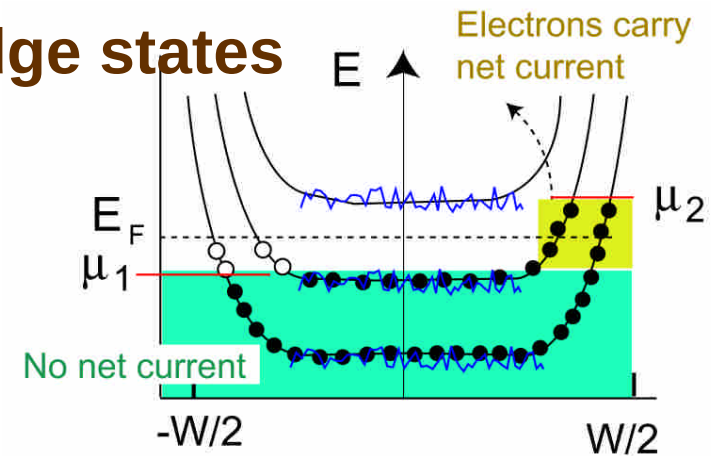
$$\left[E_c + \frac{i\hbar\nabla + eA^2}{2m^*} + U(r) \right] \psi(r) = E\psi(r)$$

$$\Rightarrow E_n = E_s + \left(n + \frac{1}{2}\right)\hbar\omega_c$$

$$\omega_c = \frac{eB}{m^*}$$



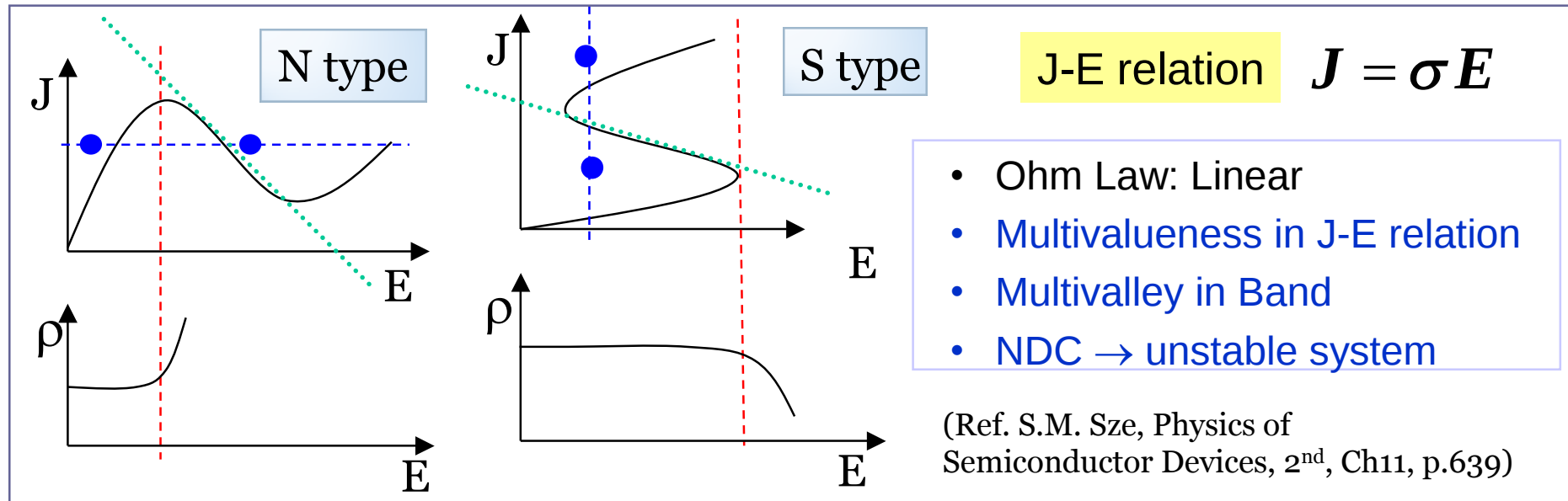
Edge states



$$R_{xy} = \frac{V_{xx}}{I} = 0 \quad \text{No scattering}$$

$$R_{xy} = \frac{V_{xy}}{I} = \frac{(\mu_1 - \mu_2)/e}{\frac{2e}{h}v(\mu_1 - \mu_2)} = \frac{h}{2e^2v}$$

Negative differential conductivity (NDC) in a bulk semiconductor



$$\left. \begin{aligned} \frac{\partial n}{\partial t} + \frac{1}{q} \frac{\partial J}{\partial x} &= 0 \\ \frac{\partial E}{\partial x} &= \frac{q(n - n_0)}{\epsilon_s} \\ J &= \sigma E - qD \frac{\partial n}{\partial x} \end{aligned} \right\}$$

$$\frac{\partial n}{\partial t} - \sigma \frac{n - n_0}{\epsilon_s} - D \frac{\partial^2 n}{\partial x^2} = 0$$

⇒ spatial response

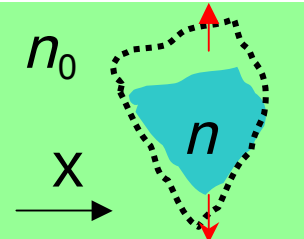
$$n - n_0 = (n - n_0)_{x=0} \exp(-x / L_D); \quad L_D = \sqrt{\frac{kT \epsilon_s}{q^2 n_0}}$$

⇒ temporal response

$$n - n_0 = (n - n_0)_{t=0} \exp(-t / \tau_R); \quad \tau_R \equiv \frac{\epsilon_s}{\sigma}$$

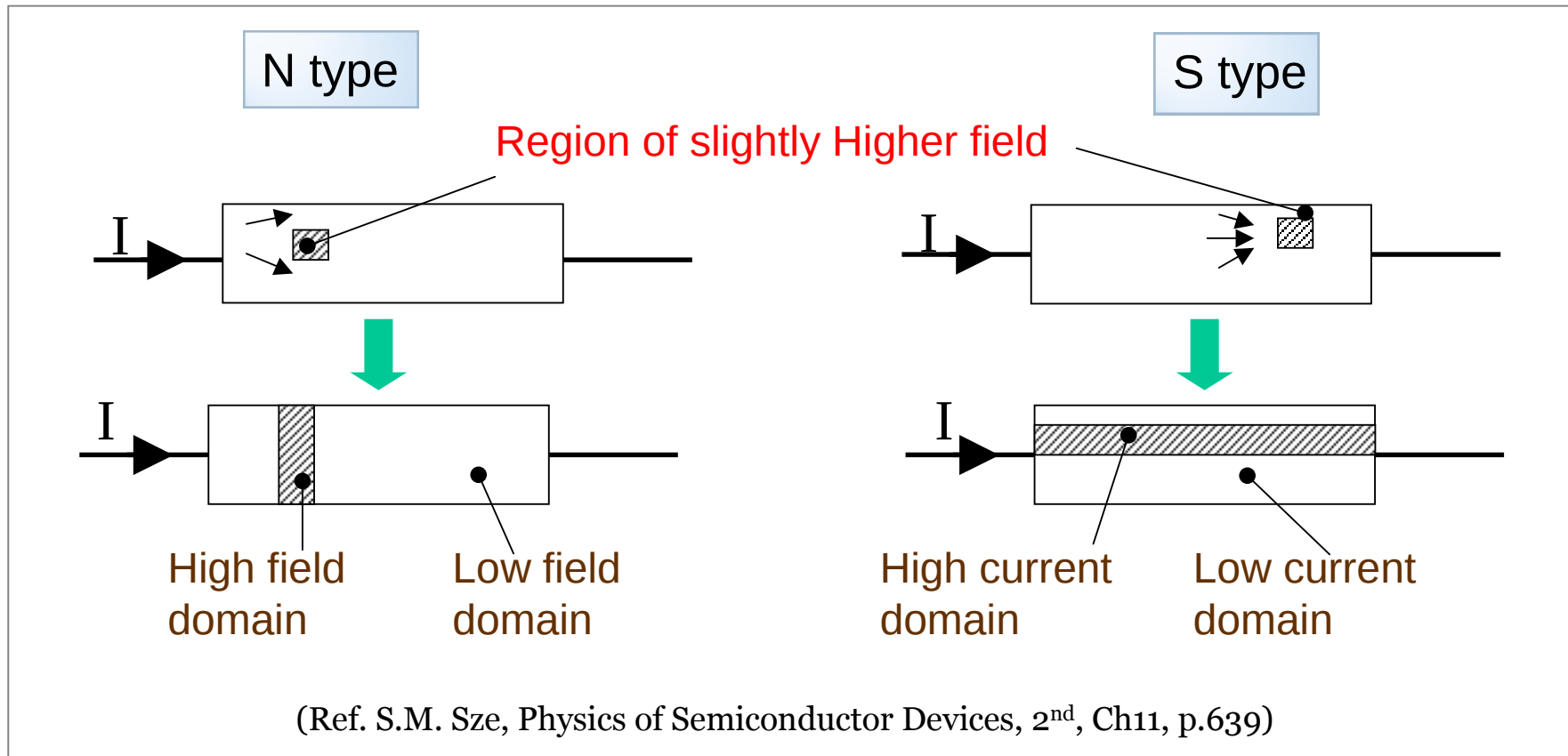
NDC ⇒ space-charge growth

Restrict spatial distribution



$\sigma < 0 \Rightarrow n - n_0 \uparrow$

Consequence of Bulk NDC



To reach the stability $\Rightarrow$ system becomes electrically heterogeneous.

What happens if the system is in a strong magnetic field?

Motivation: Microwave induced zero resistance states in 2DEG

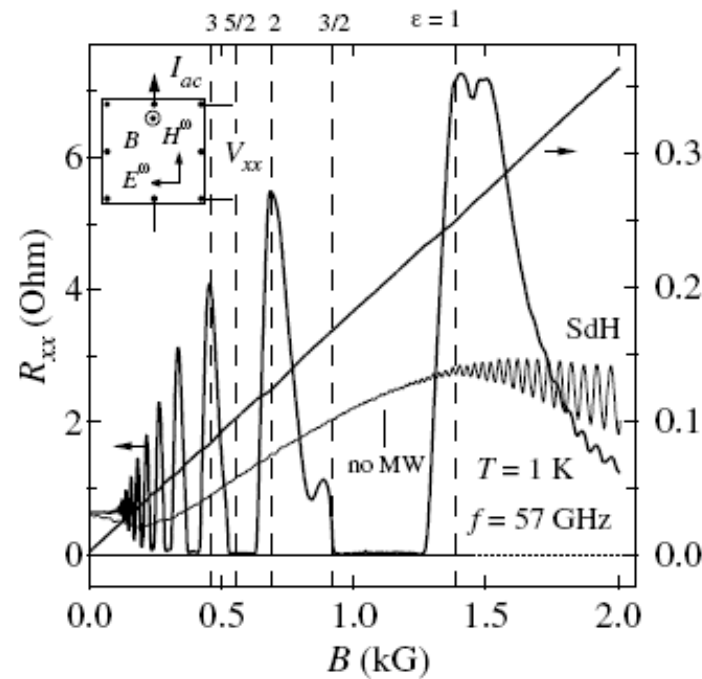
- Zero Resistance
 - Instability initiated by microwave irradiation
 - Theories based on the framework of negative differential conductivity (NDC) in bulk

Apply MW

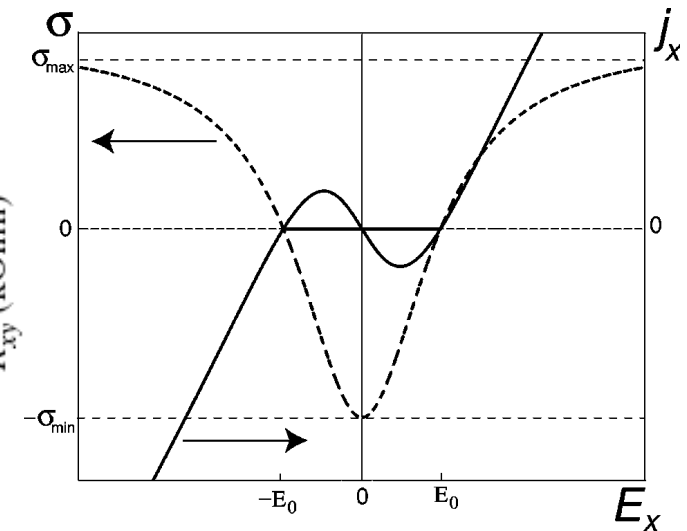
$R_{xx} \rightarrow 0$

But

$R_H \neq h/2e^2(1/\nu)$

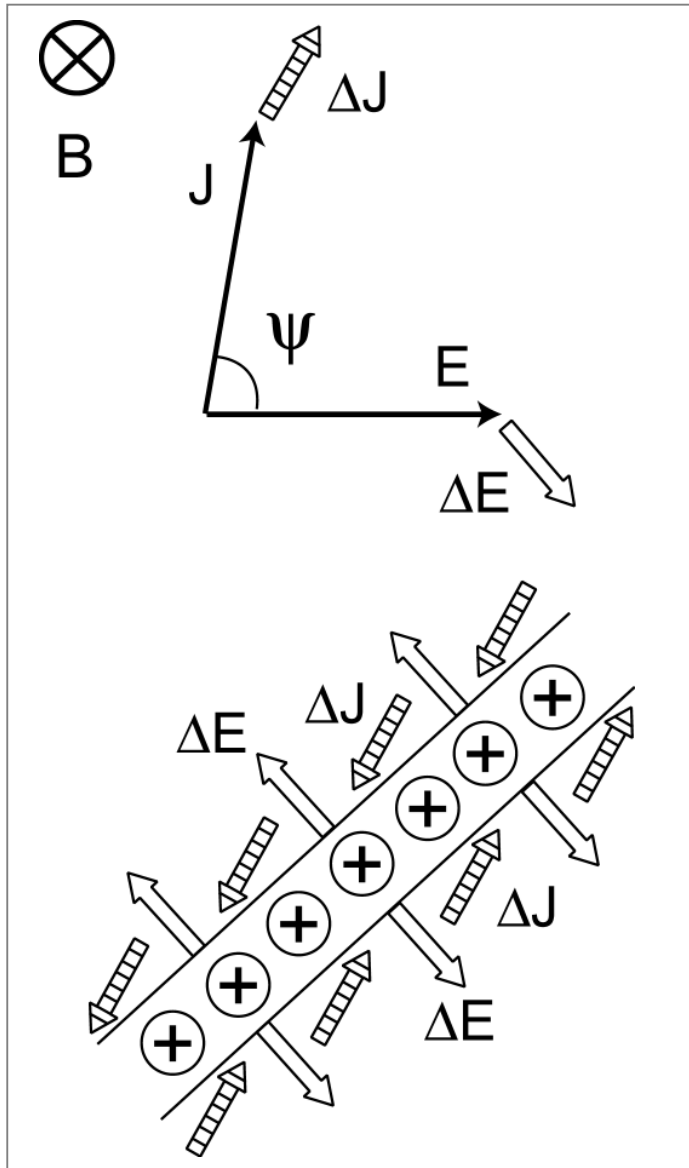


(PRL **90**, 046807, 2003)



(PRB **67**, 241303(R) 2003)

Motivation: Physical picture of NDC at high magnetic Field



Ref: Tatsumi Kurosawa, J. Phys. Soc Japan
36,491(1974)

Consider a homogeneous system with current $\mathbf{J}$, electric field $\mathbf{E}$ and magnetic field $\mathbf{H}$. $\mathbf{E} \perp \mathbf{H} // \mathbf{z}$

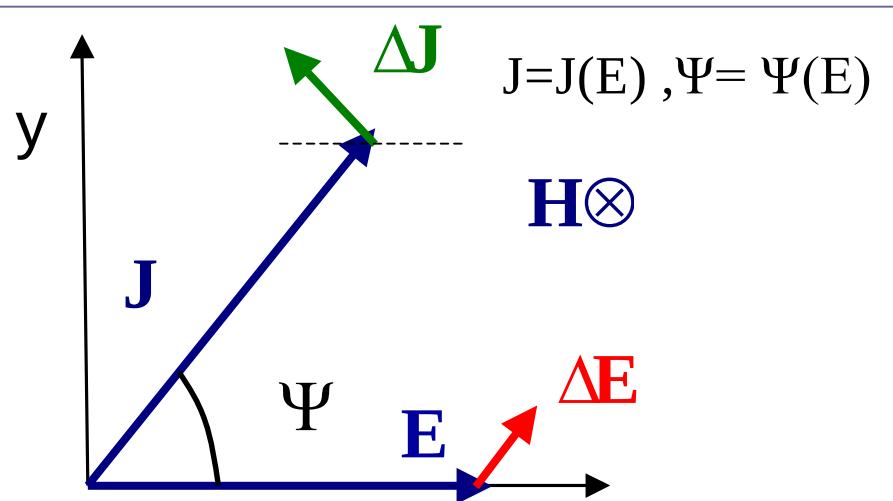
Electrical instability

- Hall angle ψ large at high B field
- Due to the growth of space charges
- Criterion:

$$\Delta \mathbf{E} \cdot \Delta \mathbf{J} < 0$$

If the condition is fulfilled, the additional current flows into the space-charge sheet and builds it up

Conditions of current instability : Kurosawa's theory



$$\Rightarrow \mathbf{J} = \begin{pmatrix} \sigma_{xx}^d & \frac{\sigma_{xy}^d + \sigma_{yx}^d}{2} \\ \frac{\sigma_{xy}^d + \sigma_{yx}^d}{2} & \sigma_{yy}^d \end{pmatrix} \mathbf{E} = \sigma_{\text{symm}}^d \mathbf{E}$$

To have negative eigenvalue(s)

$$\Rightarrow |\sigma_{\text{symm}}^d| < 0$$

i.e. satisfy $\Delta \mathbf{E} \cdot \Delta \mathbf{J} < 0$

$$J = J(E, H),$$

$$\Delta J_i = \sum_j \frac{\partial J_i}{\partial E_j} \Delta E_j = \sum_j \sigma_{ij}^d \Delta E_j$$

From symmetric consideration

$$\sigma_{xz}^d = \sigma_{yz}^d = \sigma_{zx}^d = \sigma_{zy}^d = 0$$

$$\sigma_{xx}^d = \frac{\partial J_x}{\partial E_x} = \frac{dJ}{dE} \cos \Psi - J \sin \Psi \frac{d\Psi}{dE}$$

$$\sigma_{yx}^d = \frac{\partial J_y}{\partial E_x} = \frac{dJ}{dE} \sin \Psi + J \cos \Psi \frac{d\Psi}{dE}$$

$$\sigma_{xy}^d = \frac{\partial J_x}{\partial E_y} = -\frac{J}{E} \sin \Psi$$

$$\sigma_{yy}^d = \frac{\partial J_y}{\partial E_y} = \frac{J}{E} \cos \Psi$$

Conditions of current instability : Kurosawa's theory

Define a parameter D: $D \propto \text{Det}(\sigma_{\text{symm}}^d)$

$$\underline{D = \beta^2 \tan^2 \Psi + 2\alpha(2 - \beta) \tan \Psi + \alpha^2 - 4(1 - \beta)}$$

(1)

The condition for instability: $D > 0$

When $\Psi \rightarrow \pi/2$

$\Rightarrow$ (1) is predominate

$\Rightarrow D > 0$ as long as $\beta \neq 0$

$$\Delta \mathbf{E} \cdot \Delta \mathbf{J} < 0$$

$$\Rightarrow |\sigma_{\text{symm}}^d| < 0$$

$$\alpha \equiv E \frac{d\Psi}{dE}$$

$$\beta \equiv 1 - \frac{E}{J} \frac{dJ}{dE}$$

Nonlinearity of $J(E)$

Key : Even a weak nonlinearity in $\mathbf{J-E}$ can cause the instability when $\mathbf{H}$ is strong enough !

NDC and IQHE

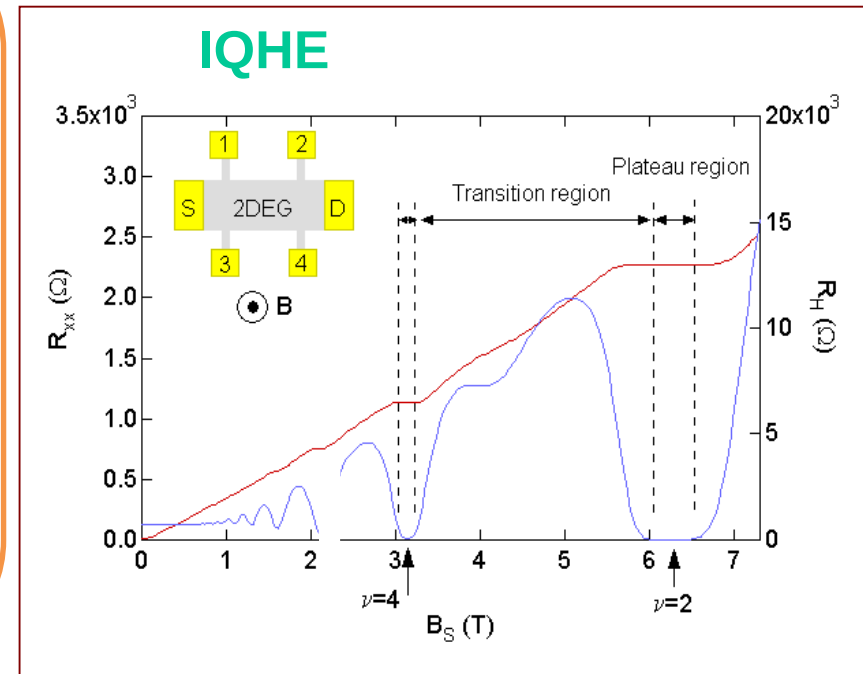
IQH states : $R_{xx}=0$, $R_{xy}=h/2e^2(1/\nu)$

$$E = \left[\left(\frac{V_{xx}}{d} \right)^2 + \left(\frac{V_{xy}}{w} \right)^2 \right]^{1/2}, \quad J = \frac{I_{SD}}{w}$$

$$\Psi = \tan^{-1} \left(\frac{E_y}{E_x} \right) \cong \tan^{-1} \left(\frac{V_{xy}}{V_{xx}} \frac{d}{w} \right)$$

$$\Rightarrow V_{xx} \rightarrow 0, \Psi \rightarrow \pi/2$$

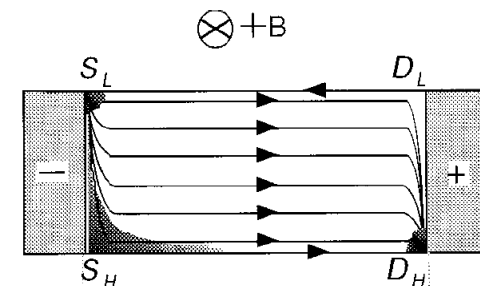
Current instability rises easily ! ?
QHE breakdown ?



Problem: inhomogeneous E-field distribution inside the sample in IQH regime

Solution: rising the lattice temperatures

Ref: Y. Kawano, etc. , Phys. Rev. B **61**, 2931(2000)

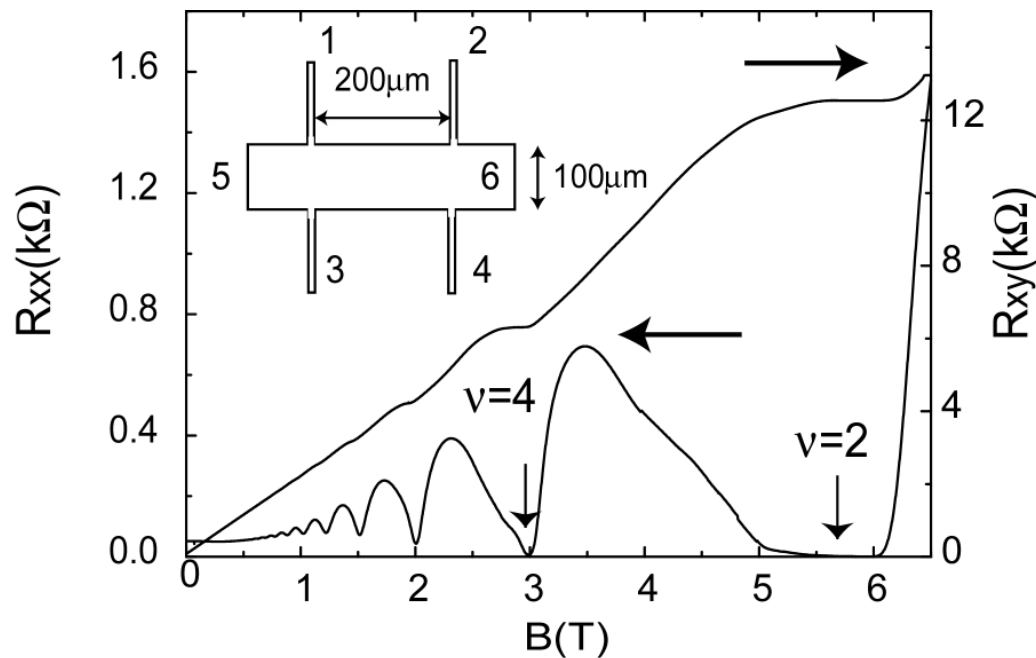


NDC in 2D Electron Gas System

Sample 1

GaAs/ $\text{Al}_{0.3}\text{Ga}_{0.6}\text{As}$
heterostructure

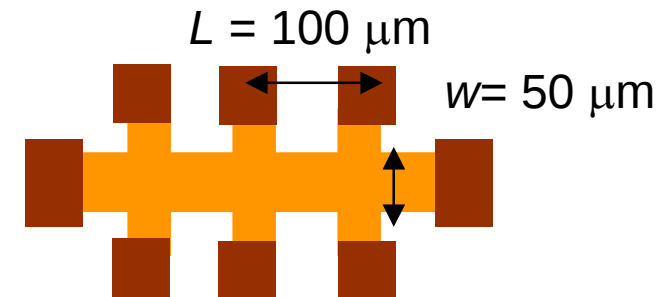
$$N_s = 3.0 \times 10^{11} \text{ cm}^{-2}$$
$$\mu = 0.8 \times 10^6 \text{ cm}^2/\text{V}\cdot\text{s}$$



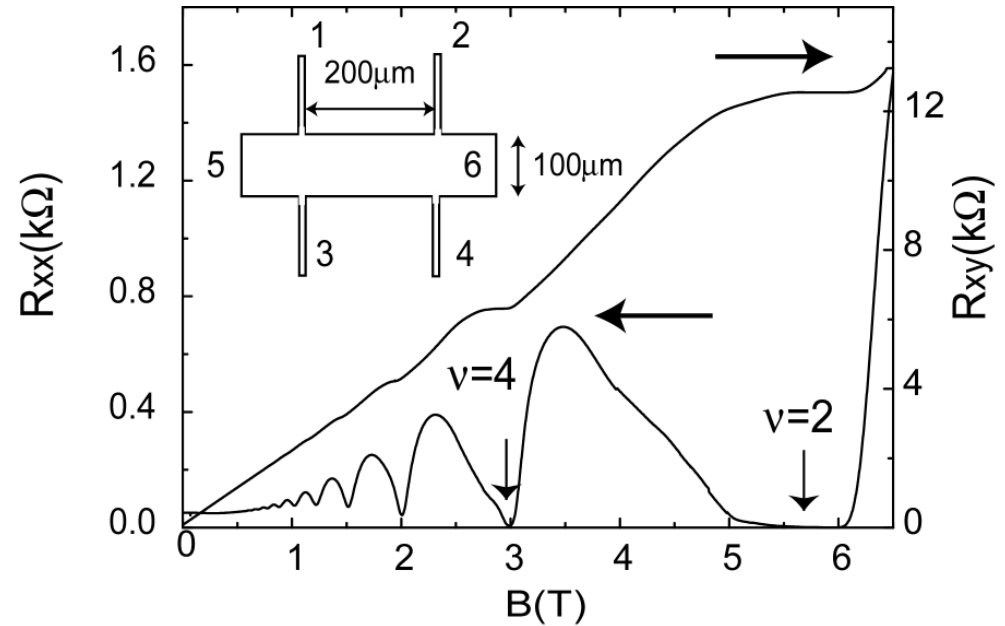
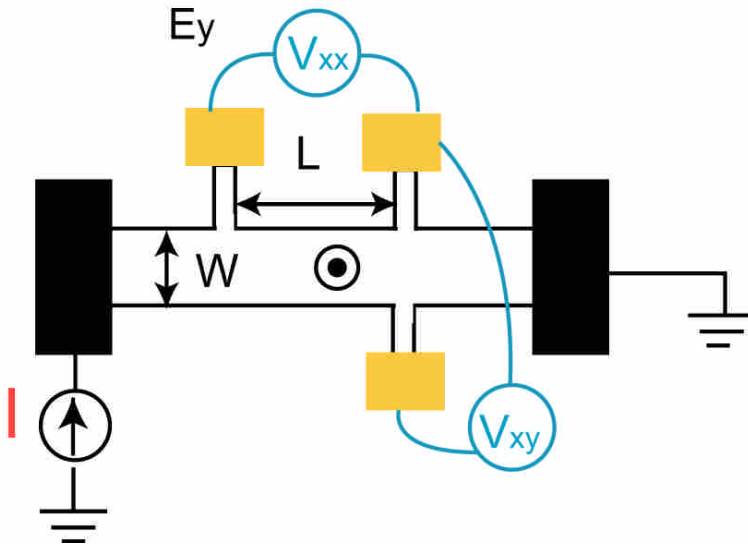
Sample 2

GaAs/ $\text{Al}_{0.3}\text{Ga}_{0.6}\text{As}$
heterostructure

$$N_s = 3.8 \times 10^{11} \text{ cm}^{-2}$$
$$\mu = 0.45 \times 10^6 \text{ cm}^2/\text{V}\cdot\text{s}$$



Match Experiment with Theory



$$E = \left[\left(\frac{V_{xx}}{L} \right)^2 + \left(\frac{V_{xy}}{W} \right)^2 \right]^{1/2}$$

$$J = \frac{I_{SD}}{W}$$

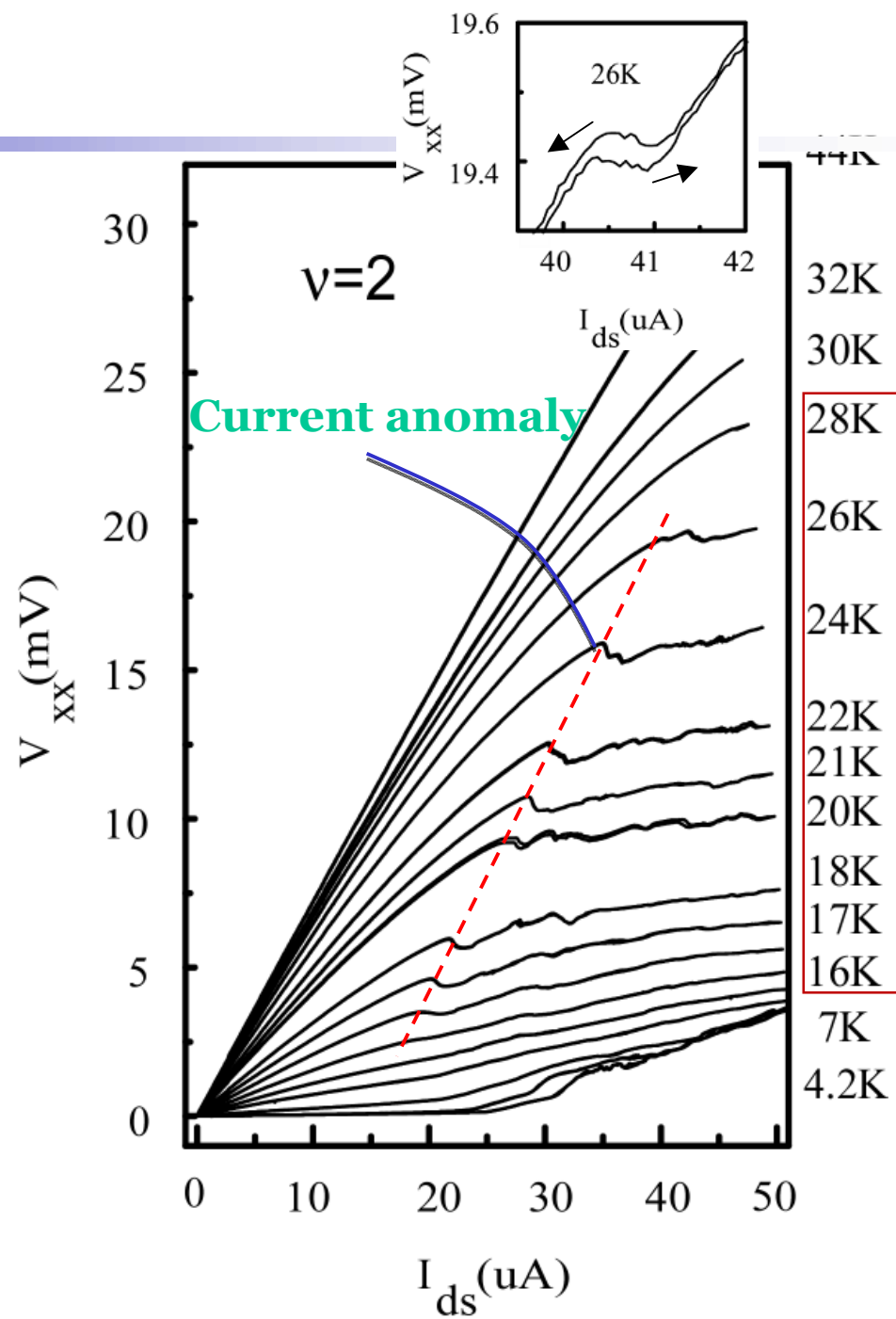
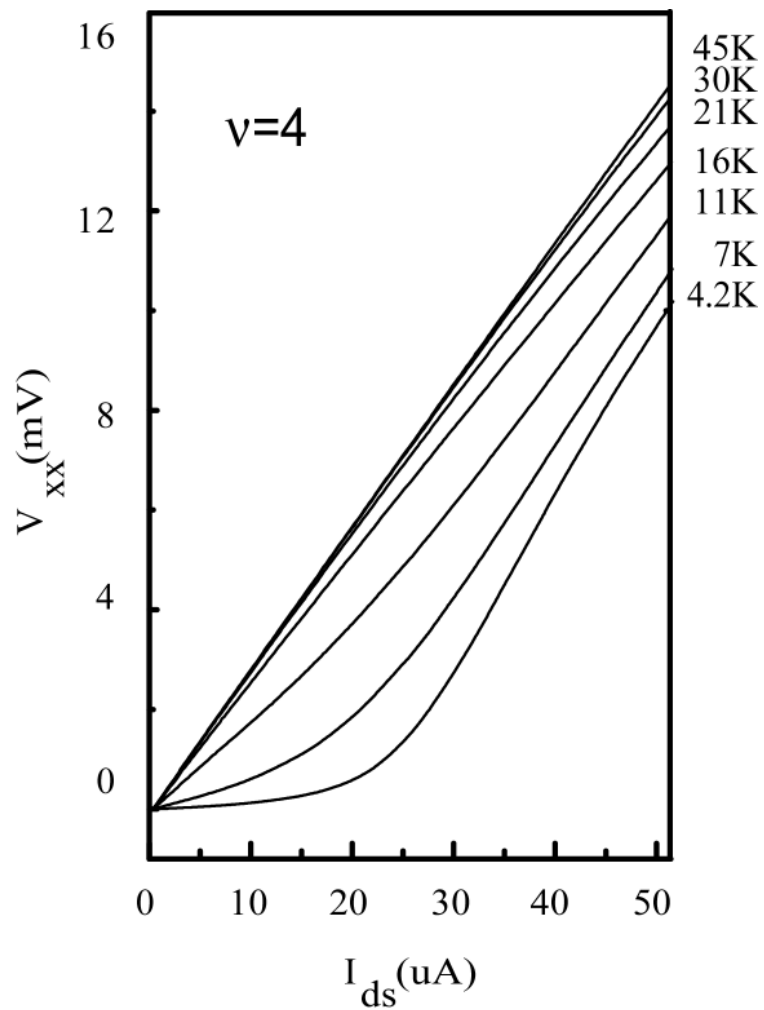
$$\Psi = \tan^{-1} \left(\frac{V_{xy}}{V_{xx}} \frac{L}{W} \right)$$



$$\left\{ \begin{array}{l} \alpha \equiv E \frac{d\Psi}{dE} \quad \& \quad \beta \equiv 1 - \frac{E}{J} \frac{dJ}{dE} \end{array} \right.$$

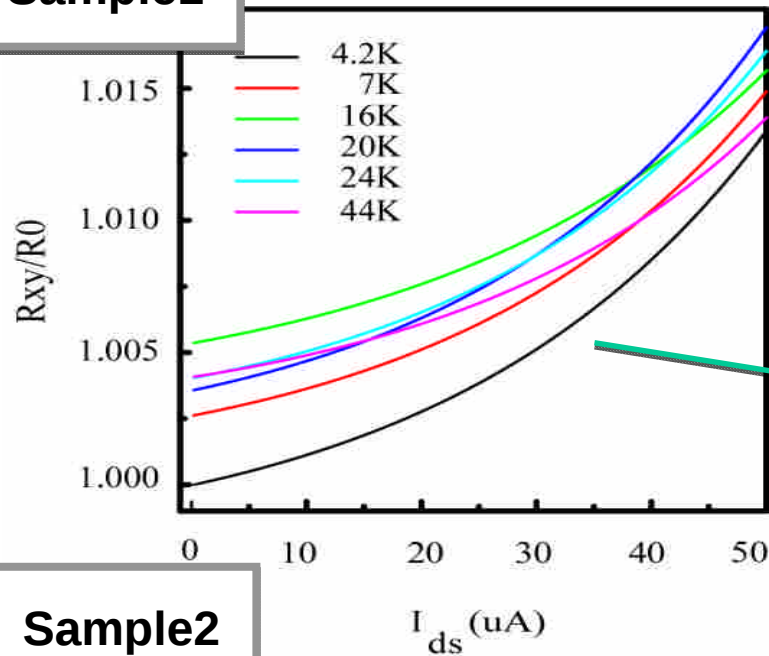
$$D = \beta^2 \tan^2 \Psi + 2\alpha(2 - \beta) \tan \Psi + \alpha^2 - 4(1 - \beta)$$

V_{xx} vs I_{SD}



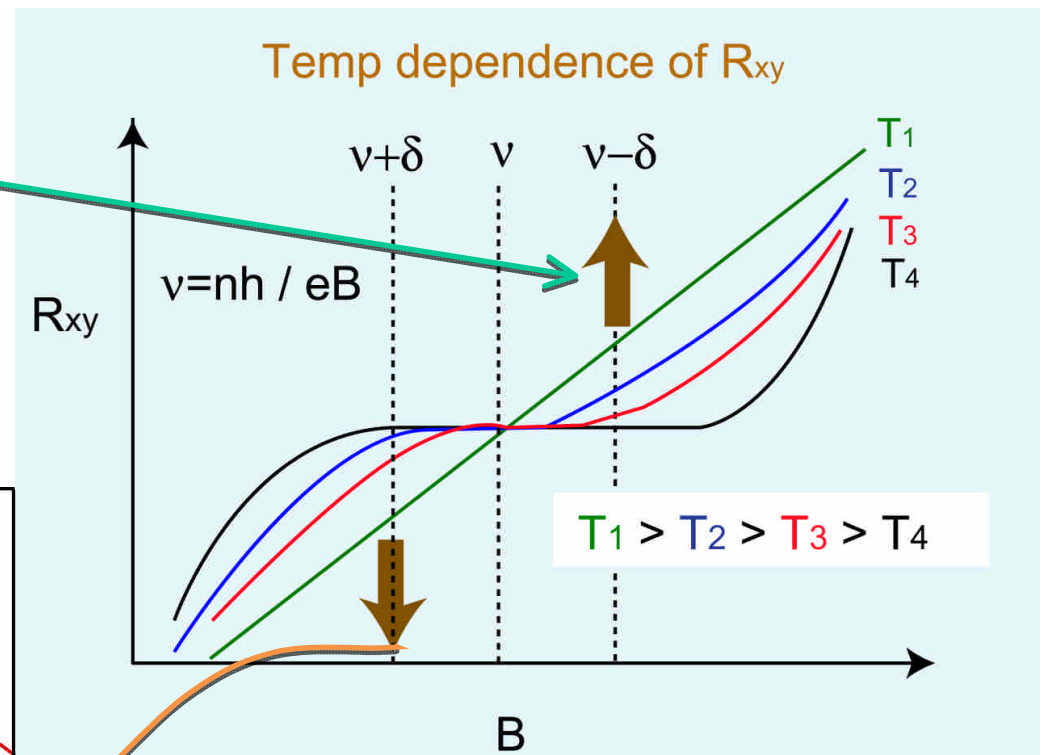
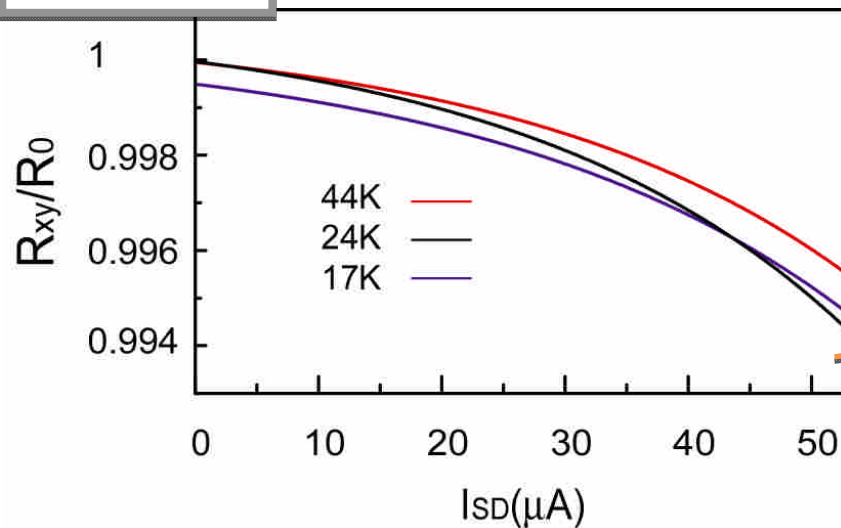
V_{xy} VS I_{SD}

Sample1



No current anomaly !

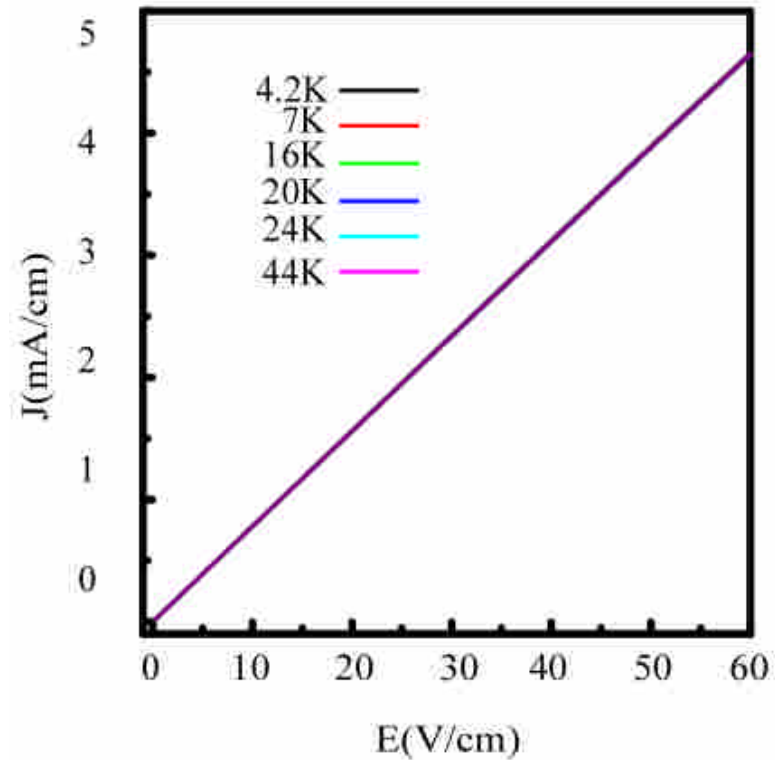
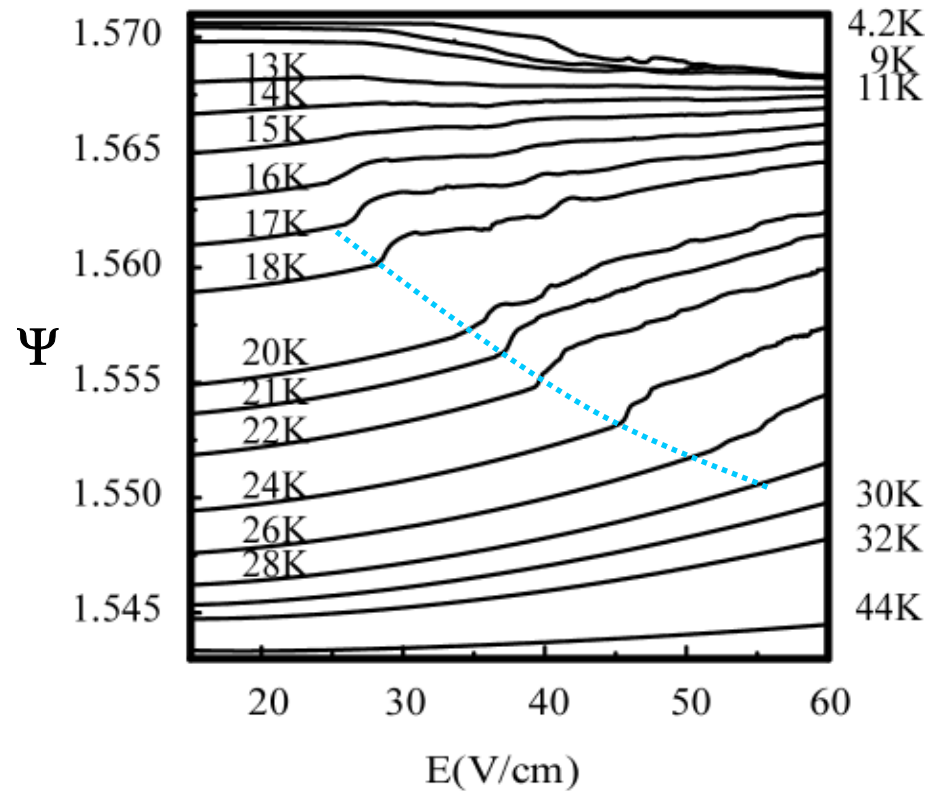
Sample2



$I_{DS} \uparrow \Rightarrow$ Electron heating $T \uparrow$

J & Ψ as Function of E

$$E = \left[\left(\frac{V_{xx}}{L} \right)^2 + \left(\frac{V_{xy}}{w} \right)^2 \right]^{1/2} ; J = \frac{I_{SD}}{w} ; \Psi = \tan^{-1} \left(\frac{V_{xy}}{V_{xx}} \frac{L}{w} \right)$$

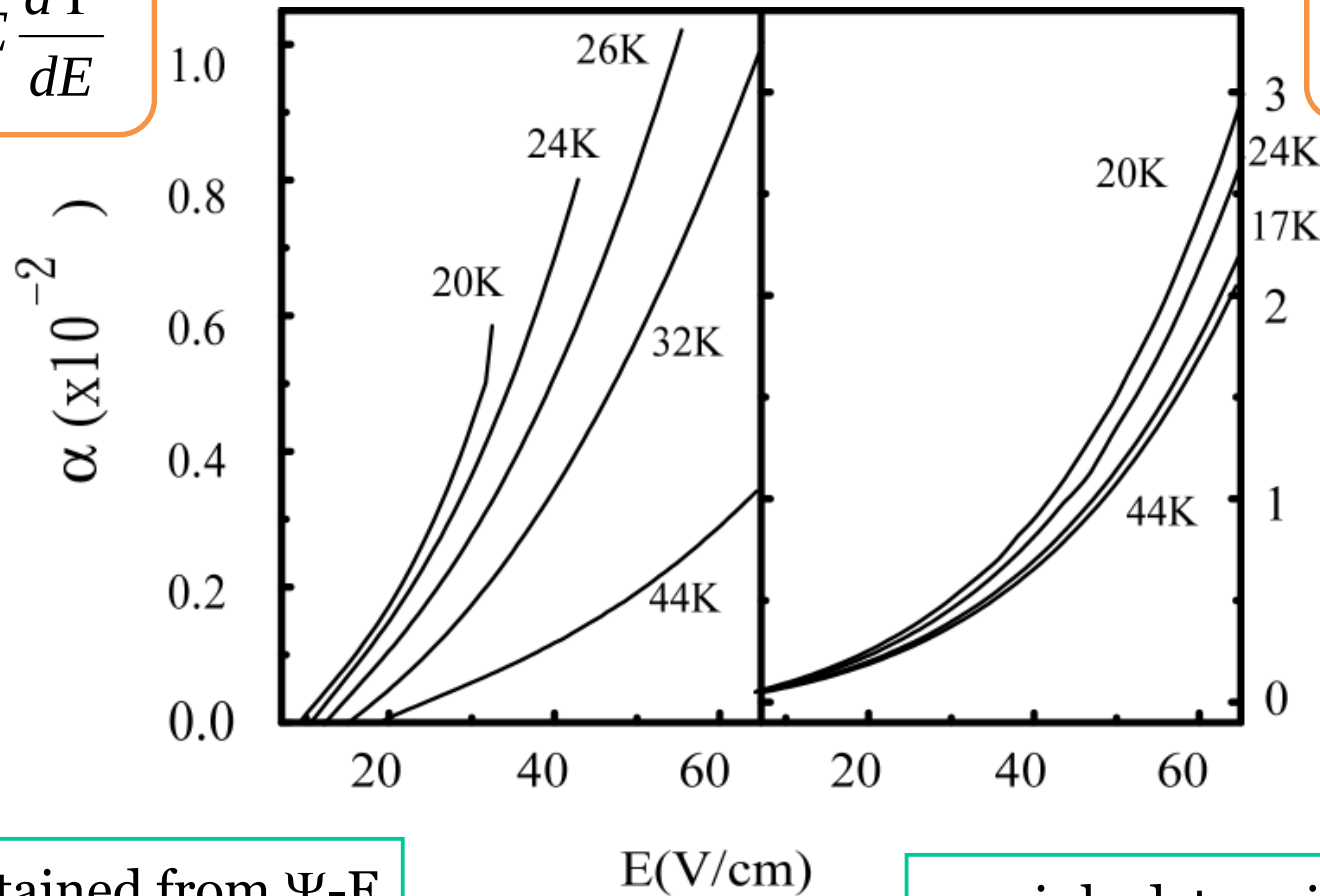


$\frac{\partial \Psi}{\partial E}$ increases abruptly

The J - E relation is almost linear and the same over different T 's

α & β as Function of E

$$\alpha \equiv E \frac{d\Psi}{dE}$$

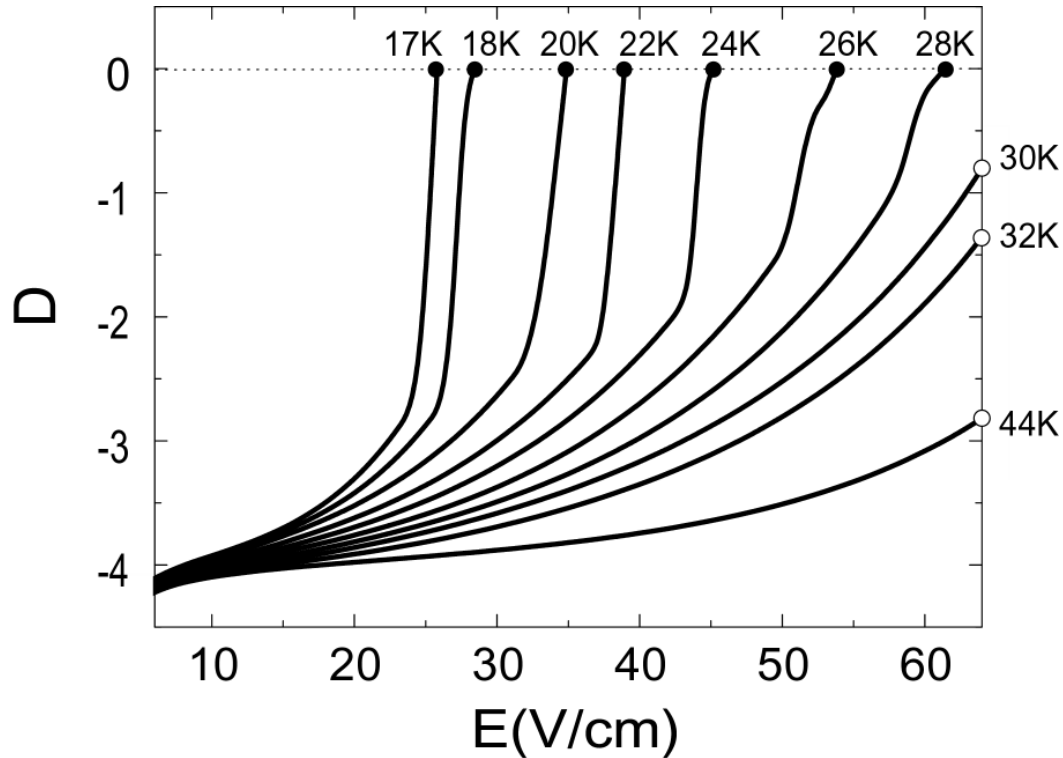


$$\beta \equiv 1 - \frac{E}{J} \frac{dJ}{dE}$$

- obtained from Ψ - E
- As $E \uparrow$, $\alpha \uparrow$
- As $T_L \uparrow$, $\alpha \downarrow$

- mainly determined by ΔV_{xy}
- As $E \uparrow$, $\beta \uparrow$
- As $T_L \uparrow$, $\beta \uparrow \downarrow$ not clear

D as Function of E



$$D = \beta^2 \tan^2 \Psi + 2\alpha(2-\beta) \tan \Psi + \alpha^2 - 4(1-\beta) > 0$$

↓
0.3

↓
2.4

↓
 10^{-4}

↓
-4

↓
 10^{-2}

"D" increases and changes its sign from negative to positive for 16K ~28K

- $\beta \cong 10^{-2} \Rightarrow$

$$\beta^2 \tan^2 \Psi \cong 0.3$$

- $\alpha \cong 10^{-2} \Rightarrow$

$$\alpha^2 \cong 10^{-4}$$

- $2\alpha(2-\beta) \tan \Psi \cong 2.4$

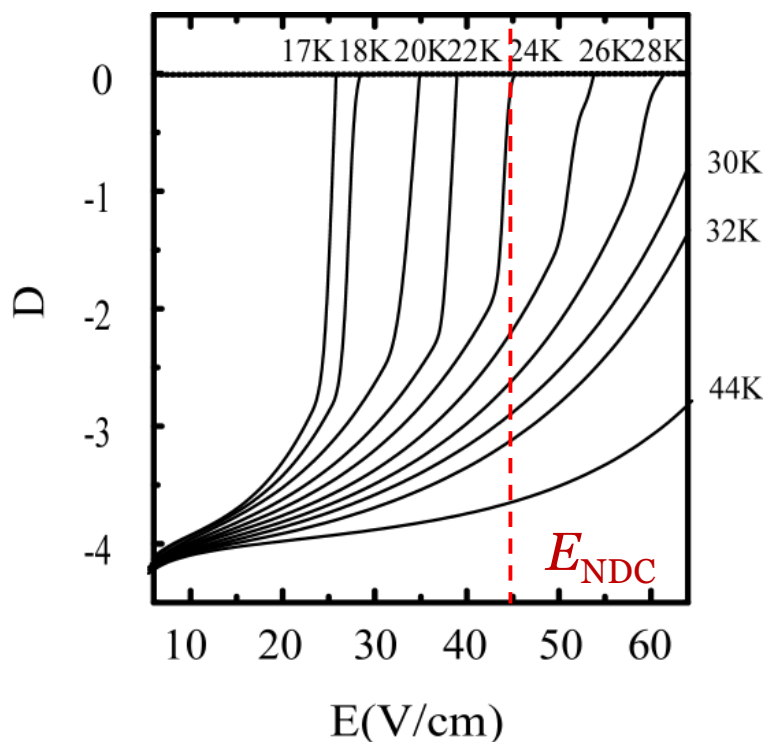
$$4(1-\beta) \cong 4$$

so $2\alpha(2-\beta) \tan \Psi - 4$

dominate the D value

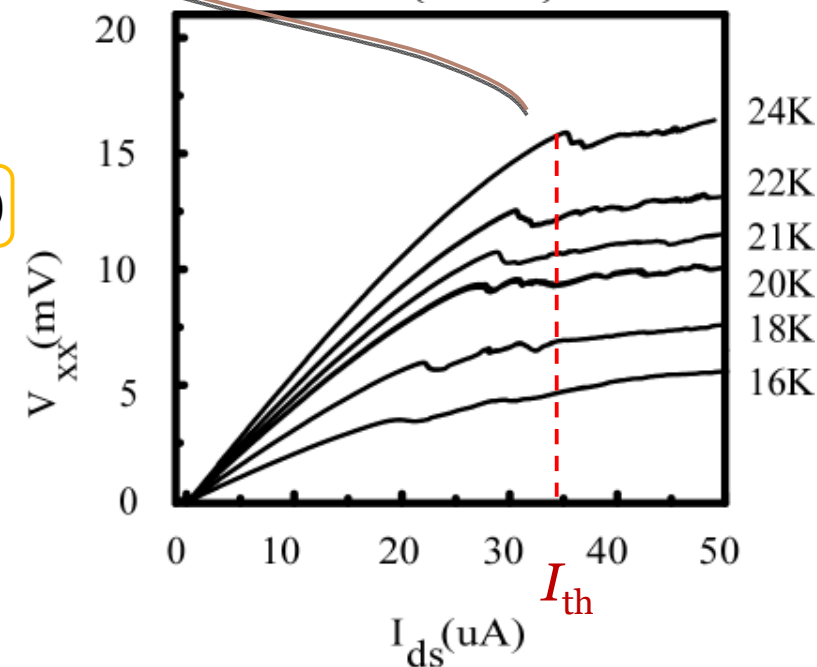
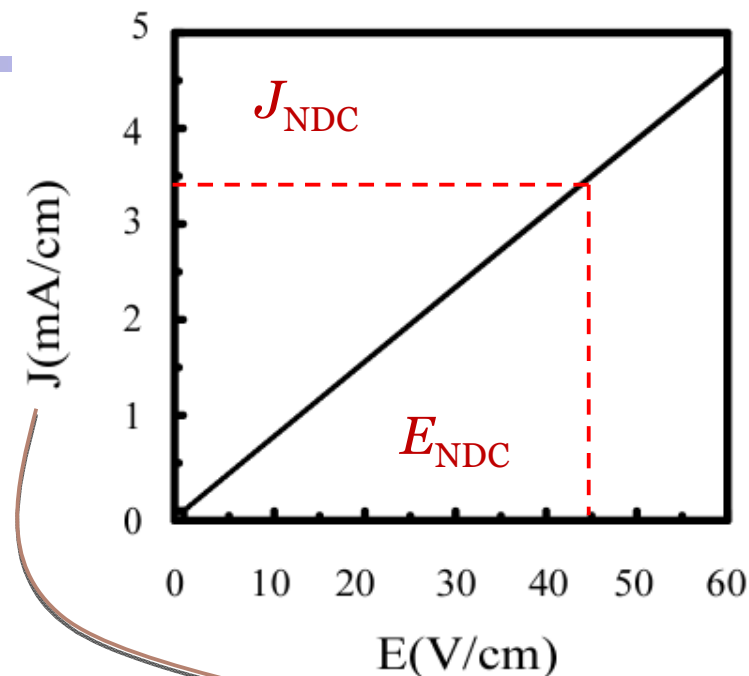
α dominates the D behavior

$$I_{\text{NDC}} = I_{\text{th}}$$



$$D = \beta^2 \tan^2 \Psi + 2\alpha(2 - \beta) \tan \Psi + \alpha^2 - 4(1 - \beta)$$

T_L	(K)	24
E_{NDC}	V/cm	45.0
I_{NDC}	μA	34.9
I_{th}	μA	35.0

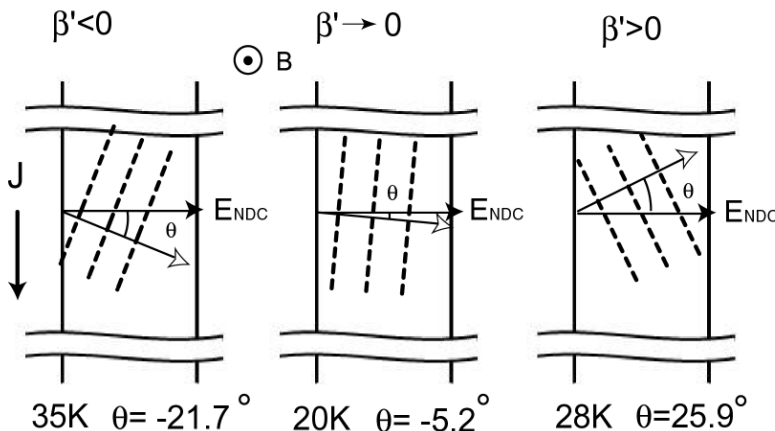


Domain growth of space charge in NDC

the angle *between* E and the eigenvector

$$\theta = \frac{\Psi + \phi}{2} - \frac{\pi}{4}$$

$$\phi \equiv \tan^{-1}\left(\frac{\beta'}{\alpha'}\right)$$



Sample 2

Sample 2

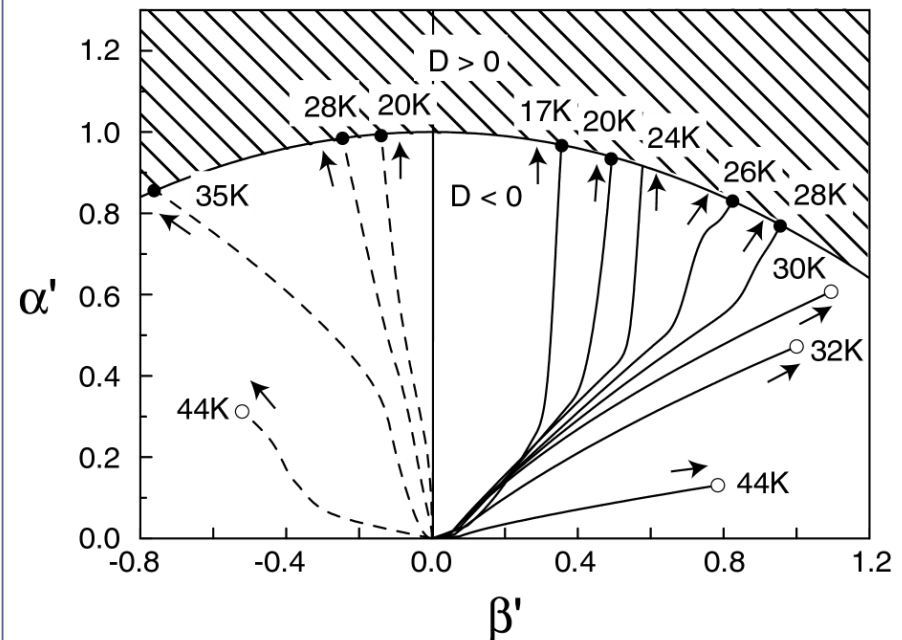
Sample 1

β dominates the growth direction

$$\alpha' = \alpha \tan \Psi \quad \beta' = \beta \tan \Psi$$

$$D = \beta^2 \tan^2 \Psi + 2\alpha(1 + \beta) \tan \Psi + \alpha^2 - 4\beta > 0$$

$$1 - \alpha' - \frac{\beta'^2}{4} < 0$$



Dependence of α' and β' on E . The arrow marks the direction of increasing E . Along the parabola the electric field reaches E_{NDC} .

Physical Origin of Instability

- Trend of Instability
 - ρ_{xx} decreases & $\Psi \rightarrow \pi/2$ as $E \uparrow$
 - Electric field gives the opposite effect to electron heating
 - i.e. Scattering rates decreases with increasing E
- $T_L > 16K$
 - Acoustic phonon scattering $\rightarrow \rho_{xx}$

Nonlinear transport in 2DEG:

- Two mechanisms
 - (a) Effects of E-field on the distribution function $f_T(\epsilon)$
 - (b) Effects of E-field on the kinematics of electron scattering
- As $\tau_{in} \gg \tau_q$, effect (a) dominates.
 - τ_{in} : inelastic scattering time
 - τ_q : quantum or single particle relaxation time
 - $f_T(\epsilon)$: at $E=0$, Fermi-distribution

DC E-field changes $f(\epsilon)$: a theoretical approach

PHYSICAL REVIEW B 71, 115316 (2005)

Theory of microwave-induced oscillations in the magnetoconductivity of a two-dimensional electron gas

I. A. Dmitriev,^{1,*} M. G. Vavilov,² I. L. Aleiner,³ A. D. Mirlin,^{1,4,†} and D. G. Polyakov^{1,*}

¹Institut für Nanotechnologie, Forschungszentrum Karlsruhe, 76021 Karlsruhe, Germany

²Center for Materials Sciences and Engineering, Massachusetts Institute of Technology, Cambridge, Massachusetts 02139, USA

³Physics Department, Columbia University, New York, New York 10027, USA

⁴Institut für Theorie der Kondensierten Materie, Universität Karlsruhe, 76128 Karlsruhe, Germany

(Received 10 February 2004; revised manuscript received 22 September 2004; published 21 March 2005)

$$\sigma_{dc}^D = \frac{e^2 v_0 v_F^2}{2 \omega_c^2 \tau_{tr}}$$

$$\tau_{tr,B} = \tau_{tr} \frac{v_0}{v(\epsilon)}$$

Kinetic equation

$$\text{St}_\omega\{f\} + \text{St}_{dc}\{f\} = -\text{St}_{in}\{f\}$$

Kubo formula

Self-consistent Born approximation

Ref: A. Dmitriev, etc. *Phys. Rev. Lett.* **91** p226802 (2003)

$$\begin{aligned} \text{St}_\omega\{f\} = & \frac{\mathcal{E}_\omega^2}{4\omega^2} \sum_{\pm} \frac{e^2 v_F^2 \tau_{tr,B}^{-1}(\epsilon + \omega) [f(\epsilon + \omega) - f(\epsilon)]}{2(\omega \pm \omega_c)^2 + \tau_{tr,B}^{-2}(\epsilon + \omega) + \tau_{tr,B}^{-2}(\epsilon)} \\ & + \{\omega \rightarrow -\omega\}. \end{aligned}$$

As $\omega \rightarrow 0$, $\text{St}_\omega\{f\} = \text{St}_{dc}\{f\}$

$$\begin{aligned} \text{St}_{dc}\{f\} &= \nu^{-1}(\epsilon) \partial_\epsilon [\nu(\epsilon) e^2 \mathcal{E}_{dc}^2 D_B(\epsilon) \partial_\epsilon f(\epsilon)] \\ &= \mathcal{E}_{dc}^2 \frac{\sigma_{dc}^D}{v_0 \tilde{\nu}(\epsilon)} \partial_\epsilon [\tilde{\nu}^2(\epsilon) \partial_\epsilon f(\epsilon)]. \end{aligned}$$

$$\begin{aligned} \mathcal{E}_\omega^2 \frac{\sigma_\omega^D}{2\omega^2 v_0} \sum_{\pm} \tilde{\nu}(\epsilon \pm \omega) [f(\epsilon \pm \omega) - f(\epsilon)] \\ + \mathcal{E}_{dc}^2 \frac{\sigma_{dc}^D}{v_0 \tilde{\nu}(\epsilon)} \partial_\epsilon [\tilde{\nu}^2(\epsilon) \partial_\epsilon f(\epsilon)] = \frac{f(\epsilon) - f_T(\epsilon)}{\tau_{in}} \end{aligned}$$

Key formula, but we only need DC term

DC E-field changes $f(\varepsilon)$: a theoretical approach

$$\sigma_{xx} = \int d\varepsilon \sigma_{dc}(\varepsilon) [-\partial_{\varepsilon} f(\varepsilon)]$$

$$\sigma_{dc}(\varepsilon) = \frac{e^2 N(\varepsilon) v_F^2}{2} \frac{\tau_{tr,B}^{-1}(\varepsilon)}{\omega_c^2 + \tau_{tr,B}^{-2}(\varepsilon)}$$

Transport relaxation time: $\tau_{tr,B}(\varepsilon) = \tau_{tr} \frac{N_0}{N(\varepsilon)}$

DOS $N(\varepsilon)$, $\tilde{N}(\varepsilon) = \frac{N(\varepsilon)}{N_0}$

DOS (2DEG): $N_0 = \frac{m}{\pi \hbar^2}$

dc Drude conductivity per spin in strong B

$$\sigma_{dc}^D = \frac{e^2 N_0 v_F^2}{2 \omega_c^2 \tau_{tr}} \quad \omega_c \tau_{tr} \gg 1$$

$$\Rightarrow \sigma_{dc}(\varepsilon) = \sigma_{dc}^D \tilde{N}^2(\varepsilon)$$

Notice : notation change
DOS $v(\varepsilon) \rightarrow N(\varepsilon)$

Stationary kinetic equation

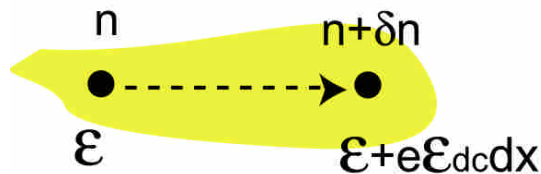
$$\varepsilon_{dc}^2 \frac{\sigma_{dc}^D}{N_0 \tilde{N}(\varepsilon)} \frac{\partial}{\partial \varepsilon} \left[\tilde{N}^2(\varepsilon) \frac{\partial}{\partial \varepsilon} f(\varepsilon) \right] = \frac{f(\varepsilon) - f_T(\varepsilon)}{\tau_{in}}$$

A simple derivation for $E_{dc} \rightarrow \delta f(\varepsilon)$

Continuous equation:

$$\frac{\partial n}{\partial t} = -\frac{\partial J}{\partial x} \quad (1)$$

$$\varepsilon \rightarrow \varepsilon + d\varepsilon = \varepsilon + e\varepsilon_{dc} dx$$



$$n \rightarrow n + \delta n$$

$$J \rightarrow J + \delta J$$

$$f \rightarrow f_T + \delta f$$

$$N(\varepsilon) \approx N_0 + \delta N$$

Diffusion coeff at B

$$D_B = \frac{v_F^2}{2} \omega_c^2 \tau_{tr,B}$$

$$\delta n = N(\varepsilon) f(\varepsilon) d\varepsilon$$

$$\frac{\partial \delta n}{\partial t} = N(\varepsilon) d\varepsilon \frac{\partial}{\partial t} f(\varepsilon) = N(\varepsilon) d\varepsilon \frac{f - f_T}{\tau_{in}}$$

$$J = -D_B \nabla n$$

$$\delta J = -D_B \nabla \delta n$$

$$\frac{\partial \delta J}{\partial x}$$

$$= -D_B \left[\frac{\partial}{\partial \varepsilon} \nabla \varepsilon \right] d\varepsilon$$

$$\frac{\partial \delta J}{\partial x} = \partial_\varepsilon \left[N(\varepsilon) D_B (e\varepsilon_{dc})^2 \partial_\varepsilon f \right] d\varepsilon \quad (3)$$

$$\text{eq(2)=eq(3)}$$

$$\Rightarrow \frac{f - f_T}{\tau_{in}} = N(\varepsilon)^{-1} \partial_\varepsilon \left[N(\varepsilon) D_B (e\varepsilon_{dc})^2 \partial_\varepsilon f \right]$$

$eE dx$ after the diffusion at distance dx
 $\Rightarrow$ translates into the diffusion in energy,
 $\varepsilon + eE dx$

DC E-field changes $f(\varepsilon)$: a theoretical approach

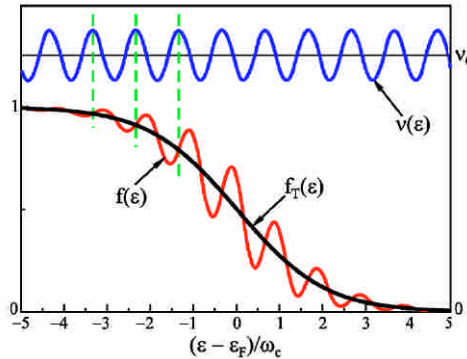
Stationary kinetic equation

$$\varepsilon_{dc}^2 \frac{\sigma_{dc}^D}{N_0 \tilde{N}(\varepsilon)} \frac{\partial}{\partial \varepsilon} \left[\tilde{N}^2(\varepsilon) \frac{\partial}{\partial \varepsilon} f(\varepsilon) \right] = \frac{f(\varepsilon) - f_T(\varepsilon)}{\tau_{in}}$$

Overlapping LL

$$\tilde{N} = 1 - 2\delta \cos \frac{2\pi\varepsilon}{\omega_c}$$

$$\delta = \exp\left(-\frac{\pi}{\omega_c \tau_q}\right) \ll 1$$



$$\frac{\sigma_{ph}}{\sigma_{dc}^D} = 1 + 2\delta^2 \left[1 - \frac{\mathcal{P}_\omega \frac{2\pi\omega}{\omega_c} \sin \frac{2\pi\omega}{\omega_c} + 4Q_{dc}}{1 + \mathcal{P}_\omega \sin^2 \frac{\pi\omega}{\omega_c} + Q_{dc}} \right]$$

As $\omega=0$

$$\Rightarrow \frac{\sigma_{xx}}{\sigma_{dc}^D} = 1 + 2\delta^2 \left(\frac{1 - 3Q_{dc}}{1 + Q_{dc}} \right)$$

$T \gg \omega$

$$\tau_{in} \sim \frac{1}{T^2}$$

$$Q_{dc} = \frac{2\tau_{in}}{\tau_{tr}} \left(\frac{eE_{dc} v_F}{\omega_c^2} \right)^2 \left(\frac{\pi}{\hbar\omega_c} \right)^2$$

$$\rho_{xx} \sim \rho_{xy}^2 \sigma_{xx}$$

$$\Rightarrow \frac{\rho_{xx}}{\rho_{xx}(E_{dc}=0)} = \frac{1 + 2\delta^2 \left(\frac{1 - 3Q_{dc}}{1 + Q_{dc}} \right)}{1 + 2\delta^2}$$

(1) Determine $\tau_{tr,B}$

$$\tau_{tr,B} = \frac{e^2 N_0 v_F^2}{2\omega_c^2 \sigma_{dc}^D}$$

$\sigma_{dc}^D \rightarrow \rho_{xx}(E \rightarrow 0)$ from V_{xx} -I

(2) Determine τ_q

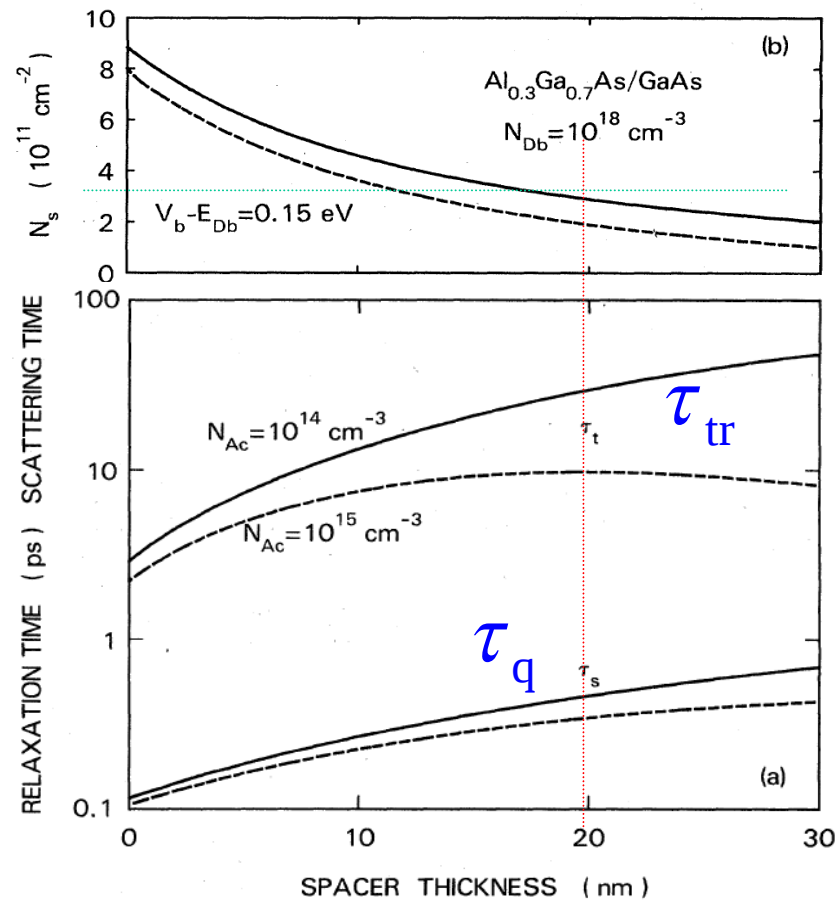
(3) Fit $\rho_{xx}(E_{dc})/\rho_{xx}(E_{dc}=0)$

fitting parameter τ_{in}

(4) Check $\tau_{in}(T)$ relation

Data analysis strategy

Determine τ_q



$$\frac{1}{\tau} = \frac{2\pi m N_i}{\hbar^3} \int \frac{d^3 k'}{(2\pi)^3} f(\theta) \left| u \left(2k_F \sin \left(\frac{\theta}{2} \right) \right) \right|^2 \frac{\delta(k' - k_F)}{k'}$$

remote impurity: addition factor $\exp(-4k_F d_s \sin(\theta/2))$

d_s : spacer thickness

Single-particle relaxation time versus scattering time in an impure electron gas

Ref. S. Das Sarma, Frank Stern. *Phys. Rev. B.* 32 p8442 (1985)

4.2K / B=0T

Assume

$\tau_{\text{tr}} = 32 \text{ ps}$

$\tau_q \sim 1.6 \text{ ps}$ (from SdH osc.)

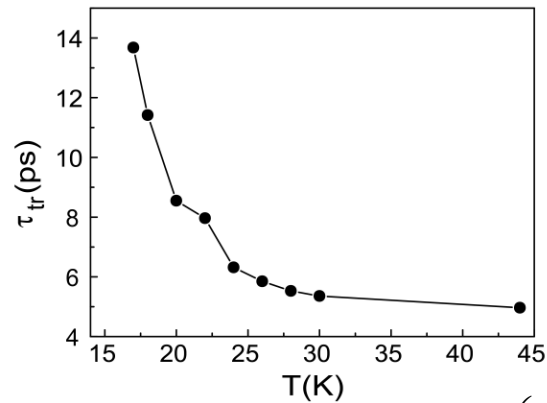
$$\frac{\tau_{\text{tr}}}{\tau_q} \sim 20$$

Our wafer structure

Uniform-dope

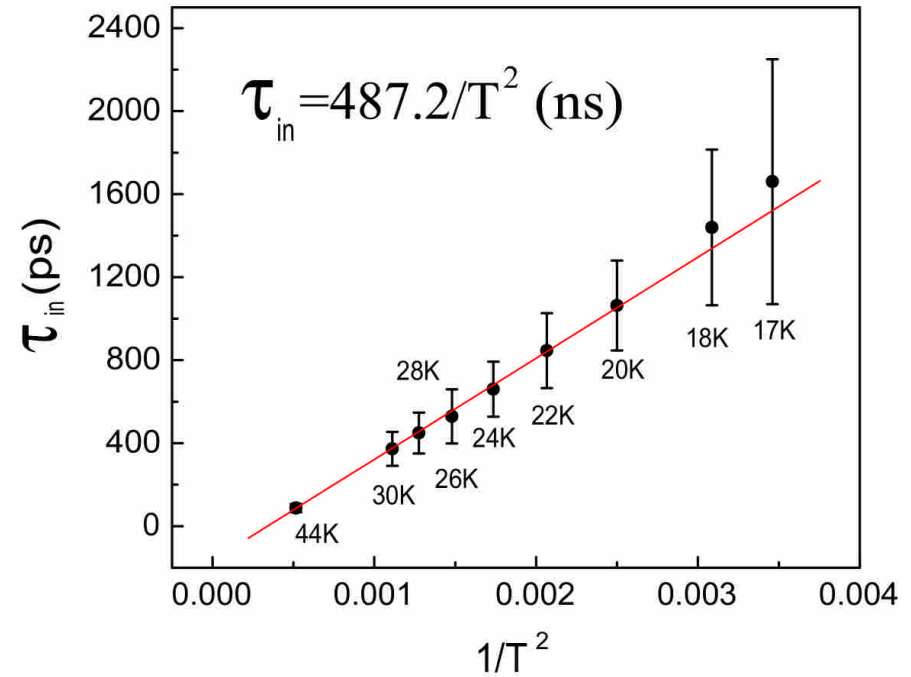
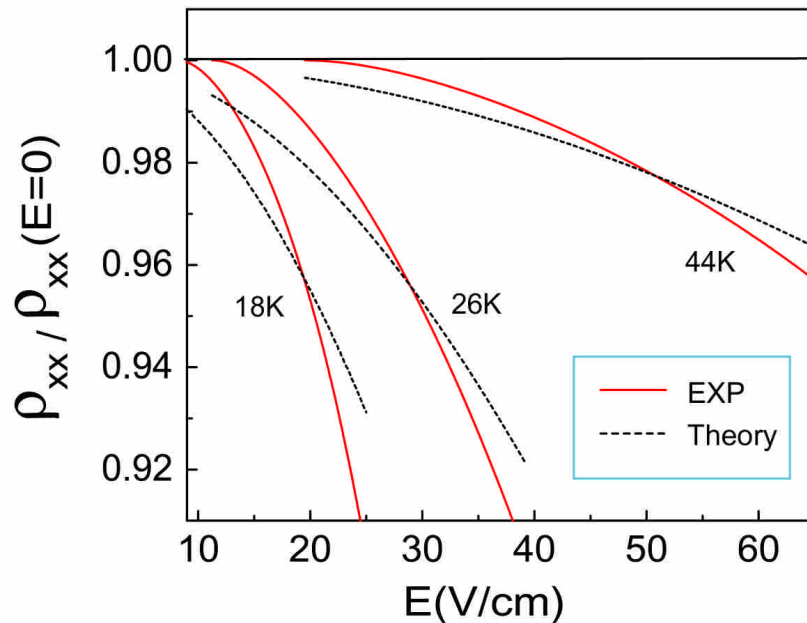
	GaAs cap layer (non-dope)	100A	
	AlGaAs (Si dope $1\text{E}+18/\text{cm}^3$)	600A	
	$x=0.33$		
	AlGaAs spacer layer (non-dope)	100A-600A	
	GaAs (non-dope)	1um	
	GaAs 100A	} * 20 times	Total 4000A
	AlGaAs 100A		
	non-dope		
	GaAs buffer layer non-dop	4000A	

Analysis results



$$\tau_{tr} = \frac{e^2 N_0 v_F^2}{2\omega_c^2 \sigma_{dc}^D}$$

$$\Rightarrow \frac{\rho_{xx}}{\rho_{xx}(E_{dc}=0)} = \frac{1 + 2\delta^2 \left(\frac{1 - 3Q_{dc}}{1 + Q_{dc}} \right)}{1 + 2\delta^2}$$



$B < 1T$

• exp: $\tau_{in} = \frac{10 \sim 12}{T^2} ns$

theory: $\tau_{in} = \frac{5 \sim 4}{T^2} ns$

Ref. *Phys. Rev. B.* 75
p081305 (2007)

Conclusion

- We have studied the current instability observed at $\nu=2$ *Hall plateau* in a 2DEG system at high lattice temperatures, $T_L \sim 17\text{-}35\text{K}$
- We demonstrate that the instability is caused by the NDC predicted by Kurosawa et al.
- The nonlinearity of the longitudinal voltages is the dominant effect to drive the system into NDC
- The nonlinearity of the Hall voltages govern the domain growth progress
- Physical origin of the nonlinearities inducing the NDC may be explained with electric field dependence of the scattering rate.